

Linear Building Block – Low Power Comparator with Op Amp and Voltage Reference

Features

- Combines Low-Power Op Amp, Comparator and Voltage Reference in a Single Package
- · Optimized for Single Supply Operation
- Small Packages: 8-Pin MSOP, 8-Pin SOIC, 8-Pin PDIP
- · Ultra Low Input Bias Current: Less than 100pA
- Low Quiescent Current: 12μA (Typ.)
- · Rail-to-Rail Inputs and Outputs
- Operates Down to V_{DD} = 1.8V, Min

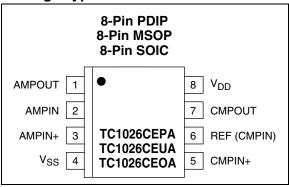
Applications

- Power Management Circuits
- · Battery Operated Equipment
- · Consumer Products

Device Selection Table

Part Number	Package	Temperature Range		
TC1026CEPA	8-Pin PDIP	-40°C to +85°C		
TC1026CEUA	8-Pin MSOP	-40°C to +85°C		
TC1026CEOA	8-Pin SOIC	-40°C to +85°C		

Package Types



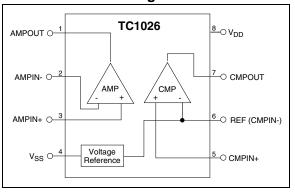
General Description

The TC1026 is a mixed-function device combining a general-purpose op amp, comparator and voltage reference in a single 8-pin package. This increased integration allows the user to replace two or three packages, which saves space, lowers supply current and increases system performance.

Both the op amp and comparator have rail-to-rail inputs and outputs which allows operation from low supply voltages with large input and output swings. The TC1026 is optimized for low voltage ($V_{DD} = 1.8V$), low supply current ($12\mu A$ typ) operation.

Packaged in a space-saving 8-Pin MSOP, the TC1026 consumes half the board area of an 8-Pin SOIC and is ideal for applications requiring high integration, small size and low power. It is also available in 8-Pin SOIC and 8-Pin PDIP packages.

Functional Block Diagram



1.0 ELECTRICAL CHARACTERISTICS

ABSOLUTE MAXIMUM RATINGS*

 Supply Voltage
 6.0V

 Package Power Dissipation:
 730 mW

 8-Pin PDIP
 470 mW

 8-Pin SOIC
 470 mW

 8-Pin MSOP
 320 mW

 Voltage on Any Pin
 (V_{SS} – 0.3V) to (V_{DD} + 0.3V)

 Junction Temperature
 +150°C

 Operating Temperature Range
 -40°C to +85°C

 Storage Temperature Range
 -55°C to +150°C

*Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions above those indicated in the operation sections of the specifications is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

TC1026 ELECTRICAL SPECIFICATIONS

Symbol	Parameter	Min	Тур	Max	Units	Test Conditions	
V _{DD}	Supply Voltage	1.8	_	5.5	V		
IQ	Supply Current	_	12	18	μΑ	All outputs unloaded	
Op Amp							
A _{VOL}	Large Signal Voltage Gain	_	100	_	V/mV	$R_L = 10k\Omega, V_{DD} = 5V$	
V _{ICMR}	Common Mode Input Range	V _{SS} - 0.2	_	V _{DD} + 0.2	V		
V _{OS}	Input Offset Voltage		±100 ±0.3	±500 ±1.5	μV mV	$V_{DD} = 3V$, $V_{CM} = 1.5V$, $T_A = 25^{\circ}C$ $T_A = -40^{\circ}C$ to 85°C	
I _B	Input Bias Current	-100	50	100	pА	$T_A = 25$ °C, $V_{CM} = V_{DD}$ to V_{SS}	
V _{OS (DRIFT)}	Input Offset Voltage Drift	_	±4	_	μV/°C	$V_{DD} = 3V, V_{CM} = 1.5V$	
GBWP	Gain-Bandwidth Product	_	90	_	kHz	$V_{DD} = 1.8V \text{ to } 5.5V;$ $V_{O} = V_{DD} \text{ to } V_{SS}$	
SR	Slew Rate	_	35	_	mV/μsec	$C_L = 100 pF$ $R_L = 1 M\Omega$ to GND Gain = 1 $V_{IN} = V_{SS}$ to V_{DD}	
V _{OUT}	Output Signal Swing	V _{SS} + 0.05	_	V _{DD} - 0.05	V	$R_L = 10k\Omega$	
CMRR	Common Mode Rejection Ratio	66	_	_	dB	$T_A = 25$ °C, $V_{DD} = 5$ V $V_{CM} = V_{DD}$ to V_{SS}	
PSRR	Power Supply Rejection Ratio	80	_	_	dB	$T_A = 25^{\circ}C, V_{CM} = V_{SS}$ $V_{DD} = 1.8V \text{ to } 5V$	
I _{SRC}	Output Source Current	3	_	_	mA	V_{IN} + = V_{DD} , V_{IN} - = V_{SS} Output Shorted to V_{SS} V_{DD} = 1.8V, Gain = 1	
I _{SINK}	Output SInk Current	_	125	_	nV/Hz	$IN+ = V_{SS}$, $IN- = V_{DD}$ Output Shorted to V_{DD} $V_{DD} = 1.8V$, $Gain = 1$	
En	Input Noise Voltage	_	10	_	μVрр	0.1Hz to 10Hz	
en	Input Noise Voltage Density	_	125		nV/√Hz	1kHz	
Comparator							
V _{IR}	Input Voltage Range	V _{SS} - 0.2		V _{DD} + 0.2	V		
V _{OS}	Input Offset Voltage	-5 -5		+5 +5	mV	$V_{DD} = 3V$, $T_A = 25$ °C $T_A = -40$ °C to 85°C	
I _B	Input Bias Current			±100	pА	$T_A = 25$ °C, IN+ = V_{DD} to V_{SS}	
V _{OH}	Output High Voltage	V _{DD} - 0.3			V	$R_L = 10k\Omega$ to V_{SS}	
V _{OL}	Output Low Voltage			0.3	V	$R_L = 10k\Omega$ to V_{DD}	

TC1026 ELECTRICAL SPECIFICATIONS (CONTINUED)

Electrical Characteristics: Typical values apply at 25°C and $V_{DD} = 3.0V$; $T_A = -40^{\circ}$ to +85°C, and $V_{DD} = 1.8V$ to 5.5V, unless otherwise specified.

Symbol	Parameter	Min	Тур	Max	Units	Test Conditions
PSRR	Power Supply Rejection Ratio	60	_	_	dB	T _A = 25°C V _{DD} = 1.8V to 5V
I _{SRC}	Output Source Current	1	_	_	mA	$IN+ = V_{DD}$ Output Shorted to V_{SS} $V_{DD} = 1.8V$
I _{SINK}	Output Sink Current	2	_	_	mA	
t _{PD1}	Response Time	_	4	_	μsec	100mV Overdrive, C _L = 100pF
t _{PD2}	Response Time	_	6	_	μsec	10mV Overdrive, C _L = 100pF
Voltage Reference						
V _{REF}	Reference Voltage	1.176	1.200	1.221	V	
I _{REF(SOURCE)}	Source Current	50	_	_	μΑ	
I _{REF(SINK)}	Sink Current	50	_	_	μΑ	
C _{L(REF)}	Load Capacitance	_	_	100	pF	

2.0 PIN DESCRIPTION

The description of the pins are listed in Table 2-1.

TABLE 2-1: PIN FUNCTION TABLE

Pin No. (8-Pin PDIP) (8-Pin MSOP) (8-Pin SOIC)	Symbol	Description	
1	AMPOUT	Op amp output.	
2	AMPIN-	Inverting op amp input.	
3	AMPIN+	Non-inverting op amp input.	
4	V_{SS}	Negative power supply.	
5	CMPIN+	Non-inverting comparator input.	
6	REF(CMPIN)	Inverting comparator input and voltage reference output voltage.	
7	CMPOUT	Comparator output.	
8	V_{DD}	Positive power supply.	

3.0 DETAILED DESCRIPTION

The TC1026 is one of a series of very low power, linear building block products targeted at low voltage, single supply applications. The TC1026 minimum operating voltage is 1.8V, and typical supply current is only 12μA. It combines a comparator, an op amp and a voltage reference in a single package.

3.1 Comparator

The TC1026 contains one comparator. The comparator's input range extends beyond both supply voltages by 200mV and the outputs will swing to within several millivolts of the supplies depending on the load current being driven. The inverting input is internally connected to the output of the reference.

The comparator exhibits propagation delay and supply current which are largely independent of supply voltage. The low input bias current and offset voltage make it suitable for high impedance precision applications.

3.2 **Operational Amplifier**

The TC1026 contains one rail-to-rail op amp. The amplifier's input range extends beyond both supplies by 200mV and the outputs will swing to within several millivolts of the supplies depending on the load current being driven.

The amplifier design is such that large signal gain, slew rate and bandwidth are largely independent of supply voltage. The low input bias current and offset voltage of the TC1026 make it suitable for precision applications.

3.3 Voltage Reference

A 2.0% tolerance, internally biased, 1.20V bandgap voltage reference is included in the TC1026. It has a push-pull output capable of sourcing and sinking at least 50μA.

TYPICAL APPLICATIONS 4.0

The TC1026 lends itself to a wide variety of applications, particularly in battery powered systems. It typically finds application in power management, processor supervisory and interface circuitry.

4.1 **External Hysteresis (Comparator)**

Hysteresis can be set externally with three resistors using positive feedback techniques (see Figure 4-1). The design procedure for setting external comparator hysteresis is as follows:

- 1. Choose the feedback resistor R_C. Since the input bias current of the comparator is at most 100pA, the current through R_C can be set to 100nA (i.e., 1000 times the input bias current) and retain excellent accuracy. The current through R_C at the comparator's trip point is V_R / R_C where V_R is a stable reference voltage.
- Determine the hysteresis voltage (V_{HY}) between the upper and lower thresholds.
- Calculate R_A as follows:

EQUATION 4-1:

$$R_A = R_C \left(\frac{V_{HY}}{V_{DD}} \right)$$

- Choose the rising threshold voltage for V_{SRC} $(V_{THR}).$
- Calculate R_B as follows:

EQUATION 4-2:

$$R_{B} = \frac{1}{\left[\left(\frac{V_{THR}}{V_{R} \times R_{A}}\right) - \frac{1}{R_{A}} - \frac{1}{R_{C}}\right]}$$

6. Verify the threshold voltages with these formulas:

V_{SRC} rising:

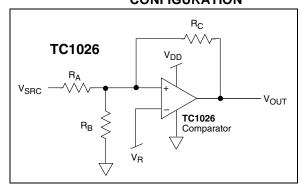
EQUATION 4-3:

$$V_{THR} = (V_R)(R_A) \left[\left(\frac{1}{R_A} \right) + \left(\frac{1}{R_B} \right) + \left(\frac{1}{R_C} \right) \right]$$

V_{SRC} falling:

EQUATION 4-4:
$$V_{THF} = V_{THR} - \left[\left(\frac{R_A \times V_{DD}}{R_C} \right) \right]$$

FIGURE 4-1: COMPARATOR EXTERNAL HYSTERESIS CONFIGURATION



4.2 Precision Battery Monitor

Figure 4-2 is a precision battery low/battery dead monitoring circuit. Typically, the battery low output warns the user that a battery dead condition is imminent. Battery dead typically initiates a forced shutdown to prevent operation at low internal supply voltages (which can cause unstable system operation).

The circuit of Figure 4-2 uses two TC1026 devices and only six external resistors. AMP 1 is a simple buffer while CMPTR1 and CMPTR2 provide precision voltage detection using V_R as a reference. Resistors R2 and R4 set the detection threshold for BATT LOW while resistors R1and R3 set the detection threshold for BATT FAIL. The component values shown assert BATT LOW at 2.2V (typical) and BATT FAIL at 2.0V (typical). Total current consumed by this circuit is typically 28 μ A at 3V. Resistors R5 and R6 provide hysteresis for comparators CMPTR1 and CMPTR2, respectively.

4.3 Voice Band Receive Filter

The majority of spectral energy for human voices is in a 2.7kHz frequency band from 300Hz to 3kHz. To properly recover a voice signal in applications such as radios, cellular phones and voice pagers, a low-power bandpass filter that is matched to the human voice spectrum can be implemented using Microchip's CMOS op amps. Figure 4-3 shows a unity-gain multipole Butterworth filter with ripple less than 0.15dB in the human voice band. The lower 3dB cut-off frequency is 70Hz (single-order response), while the upper cut-off frequency is 3.5kHz (fourth-order response).

4.4 Supervisory Audio Tone (SAT) Filter for Cellular

Supervisory Audio Tones (SAT) provide a reliable transmission path between cellular subscriber units and base stations. The SAT tone functions much like the current/voltage used in land line telephone systems to indicate that a phone is off the hook. The SAT tone may be one of three frequencies: 5970, 6000 or 6030Hz. A loss of SAT implies that channel conditions are impaired, and if SAT is interrupted for more than 5 seconds, a cellular call is terminated.

Figure 4-4 shows a high Q (30) first order SAT detection bandpass filter using Microchip's CMOS op amp architecture. This circuit nulls all frequencies except the three SAT tones of interest.

FIGURE 4-2: PRECISION BATTERY MONITOR

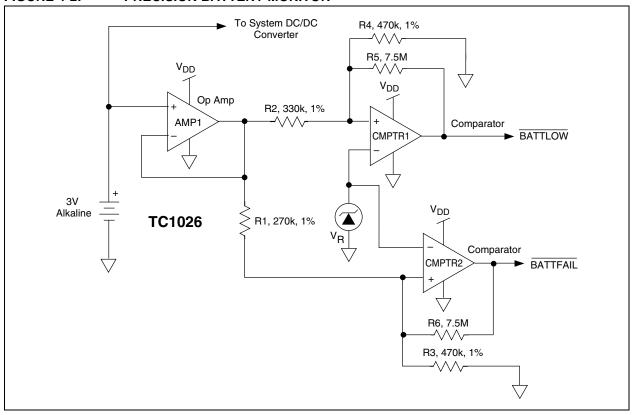


FIGURE 4-3: MULTI-POLE BUTTERWORTH VOICE BAND RECEIVE FILTER

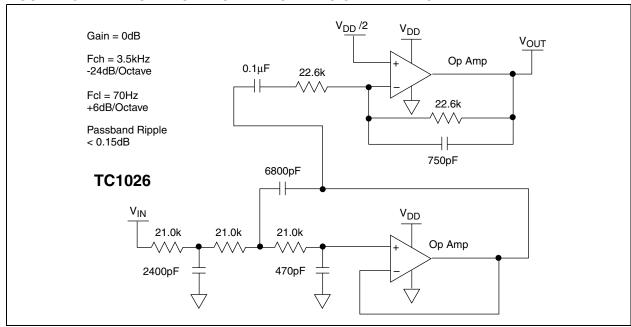
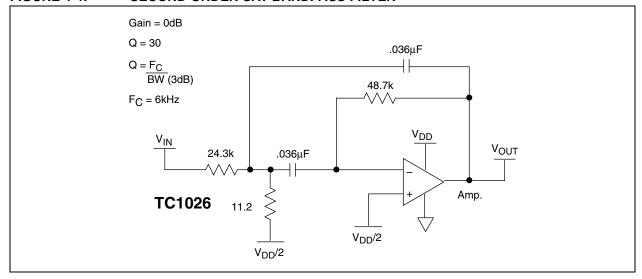
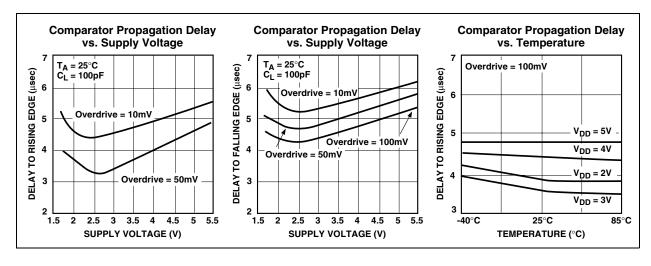


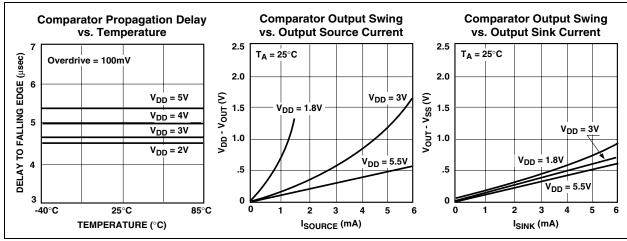
FIGURE 4-4: SECOND ORDER SAT BANDPASS FILTER

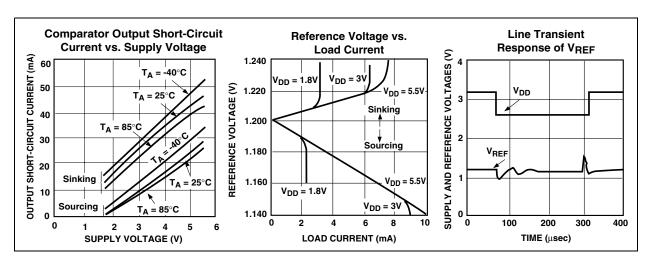


5.0 TYPICAL CHARACTERISTICS

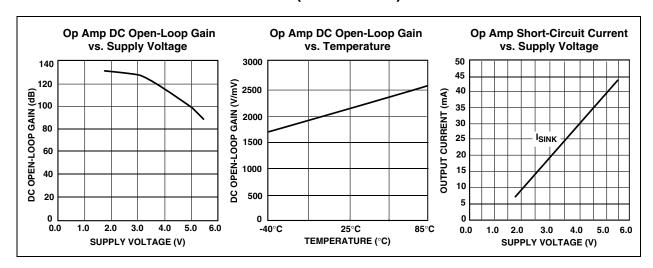
Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

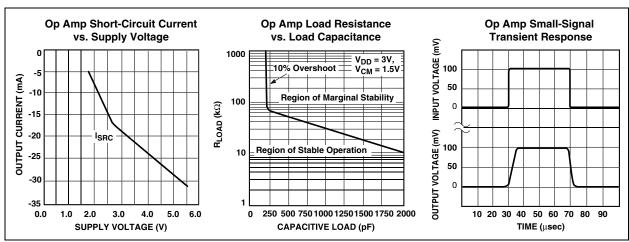


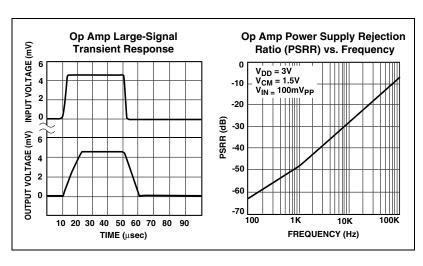




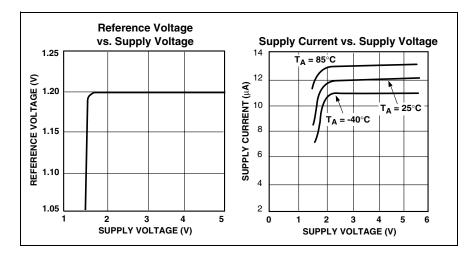
5.0 TYPICAL CHARACTERISTICS (CONTINUED)







5.0 TYPICAL CHARACTERISTICS (CONTINUED)

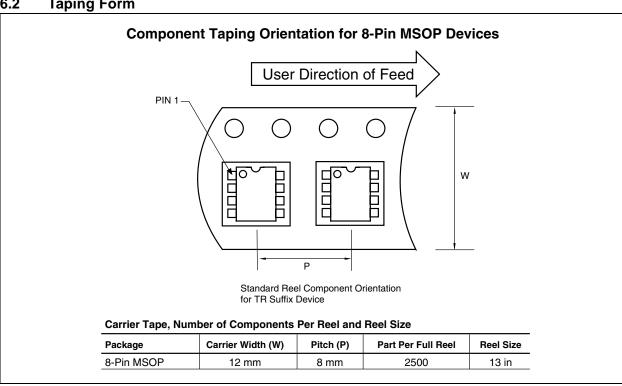


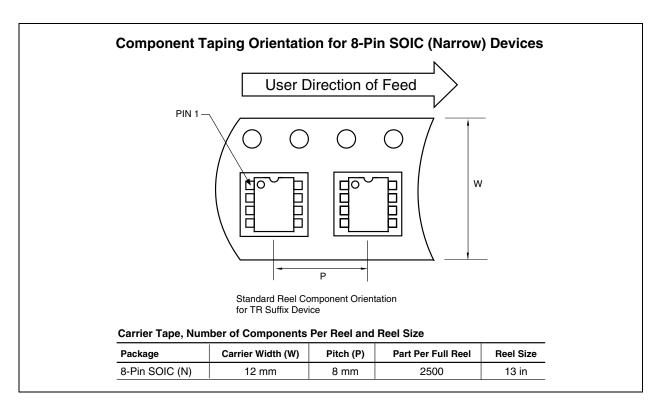
6.0 PACKAGING INFORMATION

6.1 **Package Marking Information**

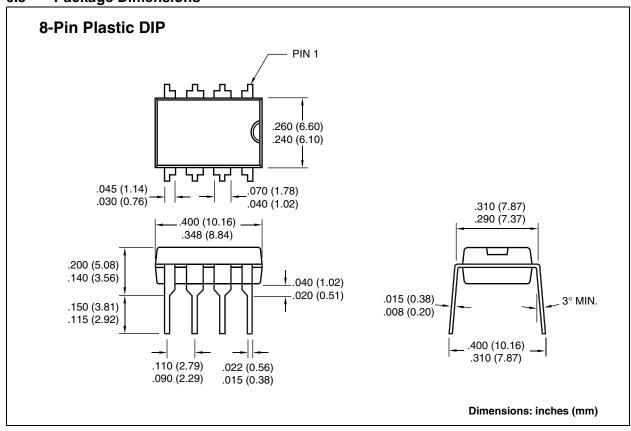
Package marking data not available at this time.

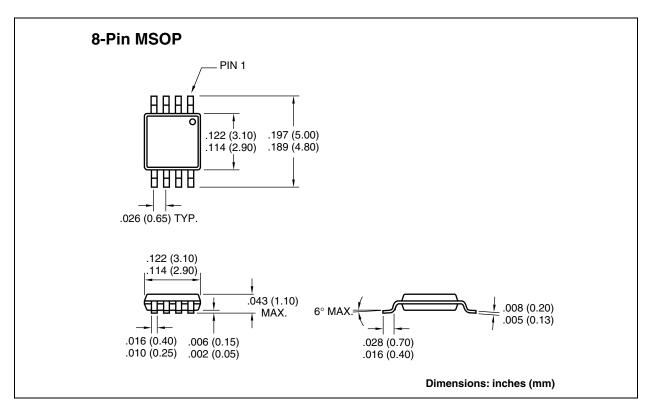
6.2 **Taping Form**



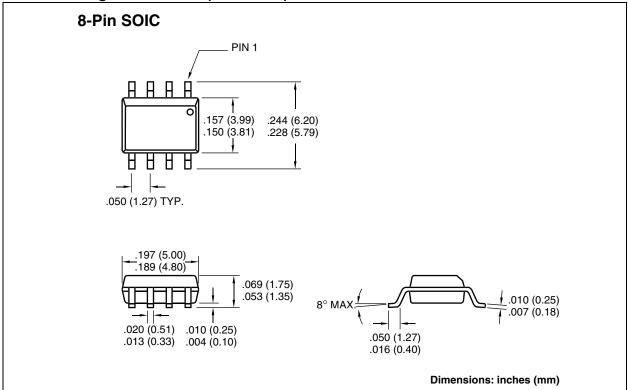


6.3 Package Dimensions





6.3 Package Dimensions (Continued)



Sales and Support

Data Sheets

Products supported by a preliminary Data Sheet may have an errata sheet describing minor operational differences and recommended workarounds. To determine if an errata sheet exists for a particular device, please contact one of the following:

- 1. Your local Microchip sales office
- 2. The Microchip Corporate Literature Center U.S. FAX: (480) 792-7277
- 3. The Microchip Worldwide Site (www.microchip.com)

Please specify which device, revision of silicon and Data Sheet (include Literature #) you are using.

New Customer Notification System

Register on our web site (www.microchip.com/cn) to receive the most current information on our products.

TC1026

NOTES:

Information contained in this publication regarding device applications and the like is intended through suggestion only and may be superseded by updates. It is your responsibility to ensure that your application meets with your specifications. No representation or warranty is given and no liability is assumed by Microchip Technology Incorporated with respect to the accuracy or use of such information, or infringement of patents or other intellectual property rights arising from such use or otherwise. Use of Microchip's products as critical components in life support systems is not authorized except with express written approval by Microchip. No licenses are conveyed, implicitly or otherwise, under any intellectual property rights.

Trademarks

The Microchip name and logo, the Microchip logo, FilterLab, KEELOQ, microID, MPLAB, PIC, PICmicro, PICMASTER, PICSTART, PRO MATE, SEEVAL and The Embedded Control Solutions Company are registered trademarks of Microchip Technology Incorporated in the U.S.A. and other countries.

dsPIC, ECONOMONITOR, FanSense, FlexROM, fuzzyLAB, In-Circuit Serial Programming, ICSP, ICEPIC, microPort, Migratable Memory, MPASM, MPLIB, MPLINK, MPSIM, MXDEV, PICC, PICDEM, PICDEM.net, rfPIC, Select Mode and Total Endurance are trademarks of Microchip Technology Incorporated in the U.S.A.

Serialized Quick Turn Programming (SQTP) is a service mark of Microchip Technology Incorporated in the U.S.A.

All other trademarks mentioned herein are property of their respective companies.

© 2002, Microchip Technology Incorporated, Printed in the U.S.A., All Rights Reserved.





Microchip received QS-9000 quality system certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona in July 1999 and Mountain View, California in March 2002. The Company's quality system processes and procedures are QS-9000 compliant for its PICmicro® 8-bit MCUs, KEELOQ® code hopping devices, Serial EEPROMs, microperipherals, non-volatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001 certified.



WORLDWIDE SALES AND SERVICE

AMERICAS

Corporate Office

2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200 Fax: 480-792-7277 Technical Support: 480-792-7627 Web Address: http://www.microchip.com

Rocky Mountain

2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7966 Fax: 480-792-7456

Atlanta

500 Sugar Mill Road, Suite 200B Atlanta, GA 30350

Tel: 770-640-0034 Fax: 770-640-0307

Boston

2 Lan Drive, Suite 120 Westford, MA 01886 Tel: 978-692-3848 Fax: 978-692-3821

Chicago

333 Pierce Road, Suite 180 Itasca, IL 60143

Tel: 630-285-0071 Fax: 630-285-0075

Dallas

4570 Westgrove Drive, Suite 160 Addison, TX 75001 Tel: 972-818-7423 Fax: 972-818-2924

Detroit

Tri-Atria Office Building 32255 Northwestern Highway, Suite 190 Farmington Hills, MI 48334 Tel: 248-538-2250 Fax: 248-538-2260

Kokomo

2767 S. Albright Road Kokomo, Indiana 46902 Tel: 765-864-8360 Fax: 765-864-8387

Los Angeles

18201 Von Karman, Suite 1090 Irvine, CA 92612

Tel: 949-263-1888 Fax: 949-263-1338

New York

150 Motor Parkway, Suite 202 Hauppauge, NY 11788 Tel: 631-273-5305 Fax: 631-273-5335

San Jose

Microchip Technology Inc. 2107 North First Street, Suite 590 San Jose, CA 95131 Tel: 408-436-7950 Fax: 408-436-7955

Toronto

6285 Northam Drive, Suite 108 Mississauga, Ontario L4V 1X5, Canada Tel: 905-673-0699 Fax: 905-673-6509

ASIA/PACIFIC

Australia

Microchip Technology Australia Pty Ltd Suite 22, 41 Rawson Street Epping 2121, NSW Australia

Tel: 61-2-9868-6733 Fax: 61-2-9868-6755

China - Beijing Microchip Technology Consulting (Shanghai)

Unit 915 Bei Hai Wan Tai Bldg. No. 6 Chaoyangmen Beidajie Beijing, 100027, No. China Tel: 86-10-85282100 Fax: 86-10-85282104

Co., Ltd., Beijing Liaison Office

China - Chengdu

Microchip Technology Consulting (Shanghai) Co., Ltd., Chengdu Liaison Office Rm. 2401, 24th Floor, Ming Xing Financial Tower No. 88 TIDU Street Chengdu 610016, China

Tel: 86-28-6766200 Fax: 86-28-6766599 China - Fuzhou

Microchip Technology Consulting (Shanghai) Co., Ltd., Fuzhou Liaison Office Unit 28F, World Trade Plaza No. 71 Wusi Road Fuzhou 350001, China Tel: 86-591-7503506 Fax: 86-591-7503521

China - Shanghai

Microchip Technology Consulting (Shanghai)

Co., Ltd. Room 701, Bldg. B Far East International Plaza No. 317 Xian Xia Road Shanghai, 200051

Tel: 86-21-6275-5700 Fax: 86-21-6275-5060

China - Shenzhen

Microchip Technology Consulting (Shanghai) Co., Ltd., Shenzhen Liaison Office Rm. 1315, 13/F, Shenzhen Kerry Centre, Renminnan Lu Shenzhen 518001, China

Tel: 86-755-2350361 Fax: 86-755-2366086

Hong Kong

Microchip Technology Hongkong Ltd. Unit 901-6, Tower 2, Metroplaza 223 Hing Fong Road Kwai Fong, N.T., Hong Kong Tel: 852-2401-1200 Fax: 852-2401-3431

India

Microchip Technology Inc. India Liaison Office Divvasree Chambers 1 Floor, Wing A (A3/A4) No. 11, O'Shaugnessey Road Bangalore, 560 025, India Tel: 91-80-2290061 Fax: 91-80-2290062

Japan

Microchip Technology Japan K.K. Benex S-1 6F 3-18-20, Shinyokohama Kohoku-Ku, Yokohama-shi Kanagawa, 222-0033, Japan Tel: 81-45-471-6166 Fax: 81-45-471-6122

Korea

Microchip Technology Korea 168-1, Youngbo Bldg. 3 Floor Samsung-Dong, Kangnam-Ku Seoul, Korea 135-882

Tel: 82-2-554-7200 Fax: 82-2-558-5934

Singapore

Microchip Technology Singapore Pte Ltd. 200 Middle Road #07-02 Prime Centre Singapore, 188980 Tel: 65-6334-8870 Fax: 65-6334-8850

Taiwan

Microchip Technology Taiwan 11F-3, No. 207 Tung Hua North Road Taipei, 105, Taiwan

Tel: 886-2-2717-7175 Fax: 886-2-2545-0139

EUROPE

Denmark

Microchip Technology Nordic ApS Regus Business Centre Lautrup hoj 1-3 Ballerup DK-2750 Denmark Tel: 45 4420 9895 Fax: 45 4420 9910

France

Microchip Technology SARL Parc d'Activite du Moulin de Massy 43 Rue du Saule Trapu Batiment A - ler Etage 91300 Massy, France Tel: 33-1-69-53-63-20 Fax: 33-1-69-30-90-79

Germany

Microchip Technology GmbH Gustav-Heinemann Ring 125 D-81739 Munich, Germany Tel: 49-89-627-144 0 Fax: 49-89-627-144-44

Italy

Microchip Technology SRL Centro Direzionale Colleoni Palazzo Taurus 1 V. Le Colleoni 1 20041 Agrate Brianza Milan, Italy
Tel: 39-039-65791-1 Fax: 39-039-6899883

United Kinadom

Arizona Microchip Technology Ltd. 505 Eskdale Road Winnersh Triangle Wokingham Berkshire, England RG41 5TU Tel: 44 118 921 5869 Fax: 44-118 921-5820

03/01/02

